Maplesemi

SLP120N06T
60V N-Channel MOSFET

General Description

This Power MOSFET is produced using Maplesemi's advanced TRENCH technology.
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

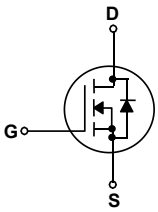
Application

☑PWM Application
☑Load Switch
☑Power Management

Features

- 120A, 60V, $R_{DS(on)Typ}$ = 4.4mΩ@V_{GS} = 10 V
- Very Low On-resistance RDS(ON)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

TO-220C
SLP120N06T



Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter		SLP120N06T	Units
V_{DSS}	Drain-Source Voltage		60	V
I_D	Drain Current - Continuous (T_C = 25℃)		120	A
	Drain Current - Continuous (T_C = 100℃)		78	A
I_{DM}	Drain Current - Pulsed	(Note 1)	360	A
V_{GSS}	Gate-Source Voltage		±20	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	564	mJ
E_{AR}	Repetitive Avalanche Energy	(Note 1)	245	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation (T_C = 25℃)		320	W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.40	℃/W
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	℃
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	℃

* Drain current limited by maximum junction temperature.

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Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLP120N06T	SLP120N06T	TO-220C	Tube	1000	5000

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 uA	60	--	--	V
$\triangle BV_{DSS}$ / $\triangle T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250 uA, Referenced to 25℃	--	0.06	--	V/℃
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 60 V, V_{GS} = 0 V	--	--	1	uA
		V_{DS} = 48 V, T_C = 150℃	--	--	10	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 20V, V_{DS} = 0 V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -20 V, V_{DS} = 0 V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 uA	2	--	4	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 30 A	--	4.4	5.5	mΩ
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	--	5540	--	pF
C_{oss}	Output Capacitance		--	420	--	pF
C_{rss}	Reverse Transfer Capacitance		--	390	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 30 V, I_D = 60 A, R_G = 1 Ω, R_L = 0.4Ω (Note 4, 5)	--	17	--	ns
t_r	Turn-On Rise Time		--	16	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	35	--	ns
t_f	Turn-Off Fall Time		--	13	--	ns
Q_g	Total Gate Charge	V_{DS} = 30 V, I_D =60 A, V_{GS} = 10 V (Note 4, 5)	--	141	--	nC
Q_{gs}	Gate-Source Charge		--	37	--	nC
Q_{gd}	Gate-Drain Charge		--	47	--	nC
R_G	Gate Resistance	f = 1MHz	--	1.7	--	Ω
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	120	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	360	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 60 A	--	--	1.4	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_S =60 A, dI_F / dt = 100 A/us (Note 4)	--	55	--	ns
Q_{rr}	Reverse Recovery Charge		--	70	--	nC

Notes:
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. I_{AS} =I_D, V_{DD} =30V, R_G = 25Ω, Starting T_J = 25°C
3. $I_{SD} \leq I_D$, di/dt ≤ 200A/us, $V_{DD} \leq BV_{DSS,}$ Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

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N- Channel Typical Characteristics

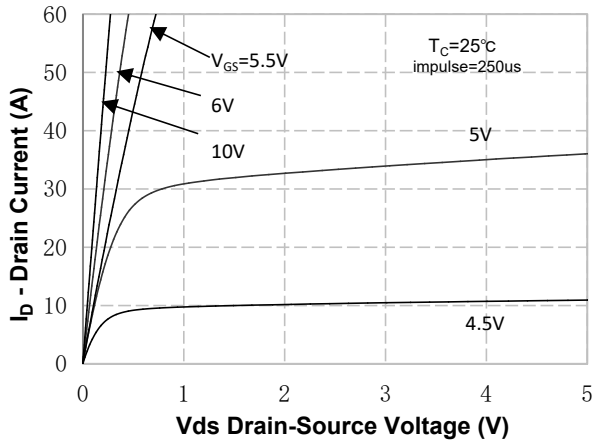

Figure 1. On-Region Characteristics

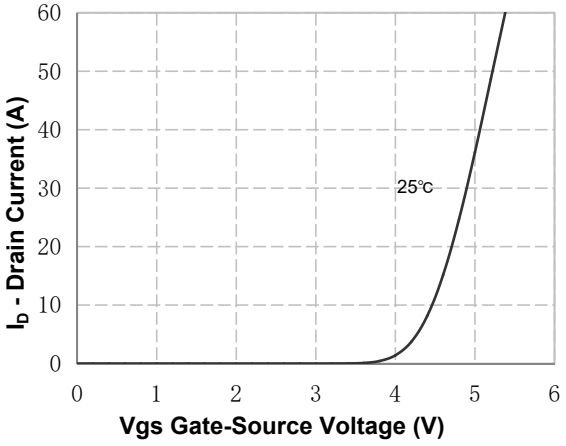

Figure 2. Transfer Characteristics

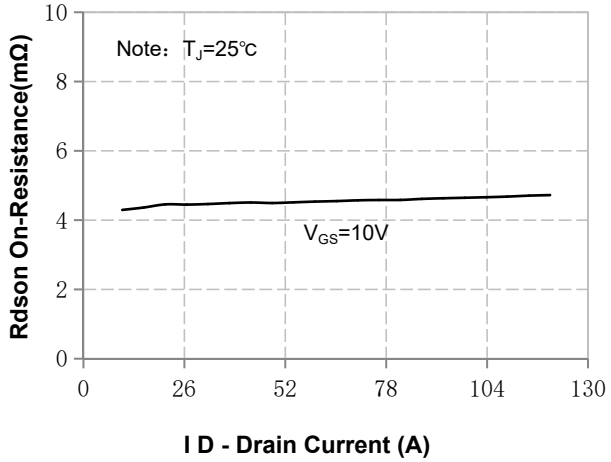

Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

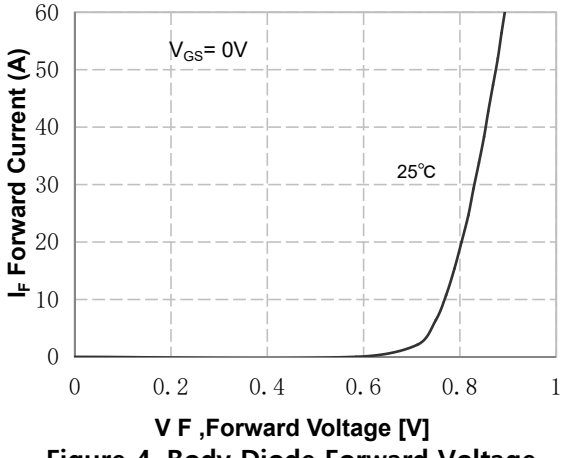

Figure 4. Body Diode Forward Voltage Variation with Source Current

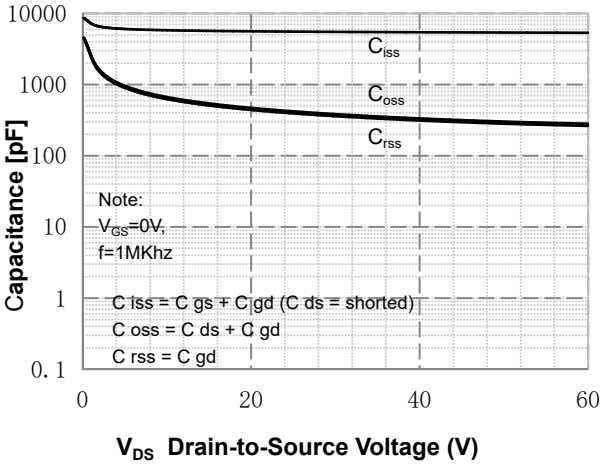

Figure 5. Capacitance Characteristics

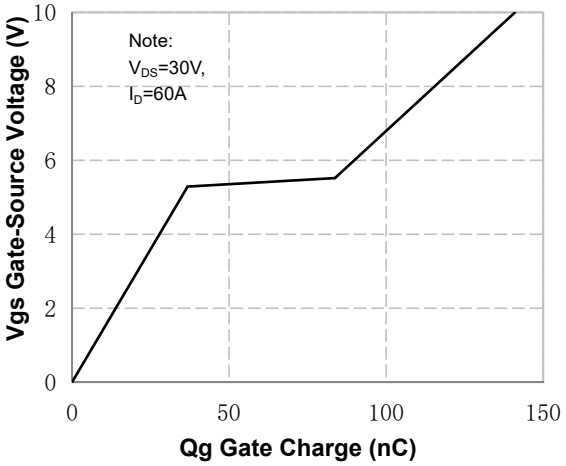

Figure 6. Gate Charge Characteristics

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N- Channel Typical Characteristics (Continued)

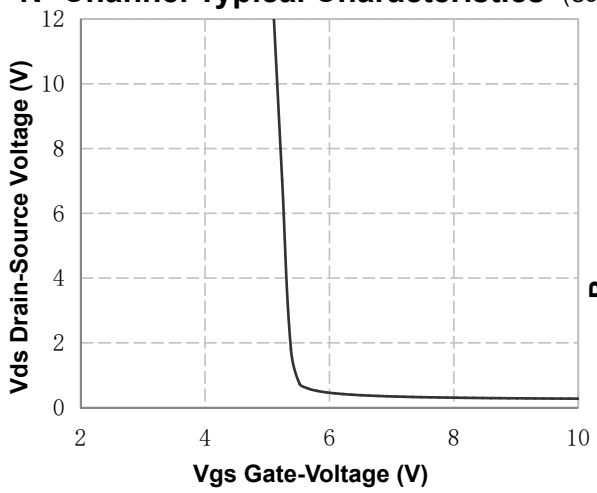

Figure 7. Vds Drain-Source Voltage vs Gate Voltage

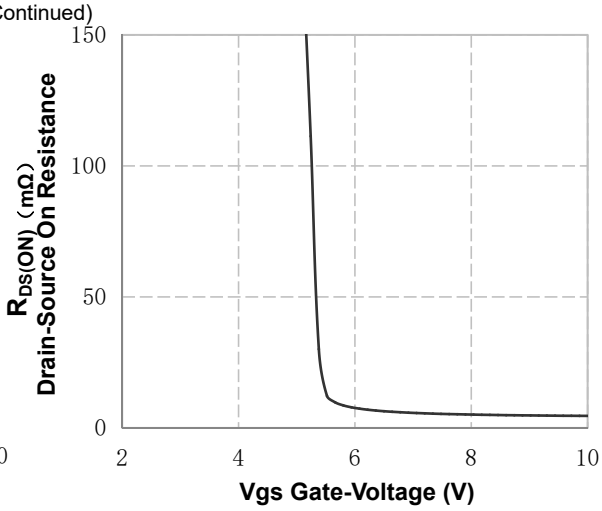

Figure 8. On-Resistance vs Gate Voltage

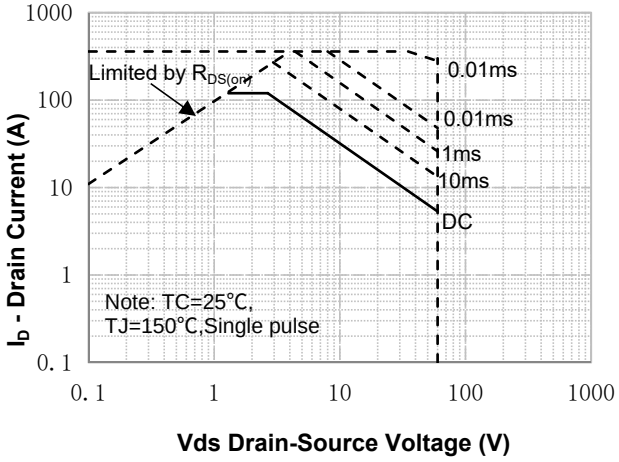

Figure 9. Maximum Safe Operating Area

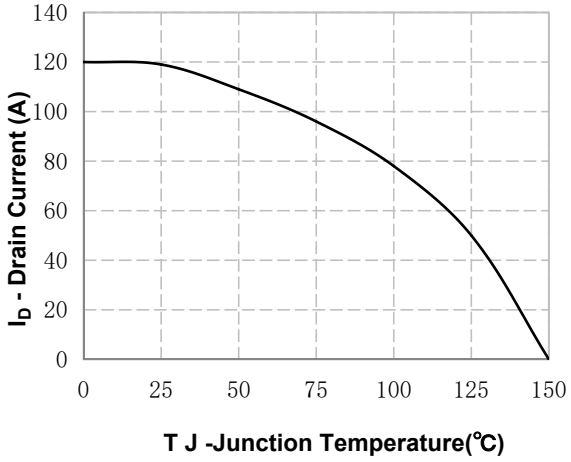

Figure 10. Maximum Continuous Drain Current vs Case Temperature

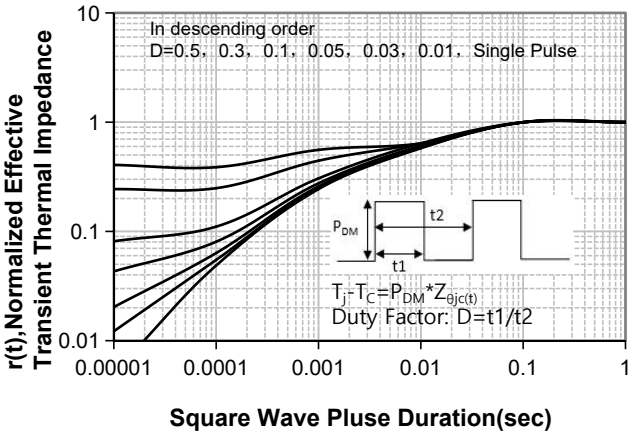

Figure 11. Transient Thermal Response Curve

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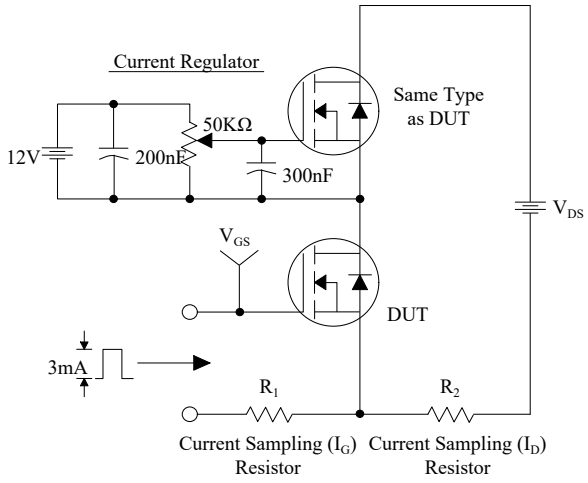
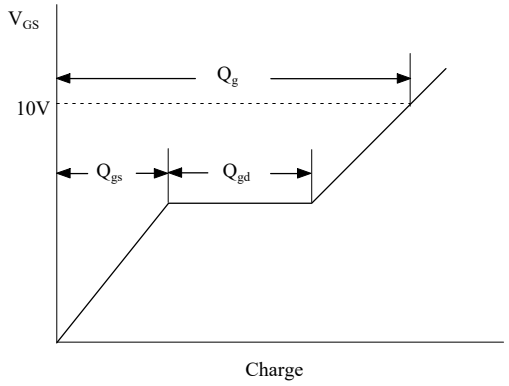
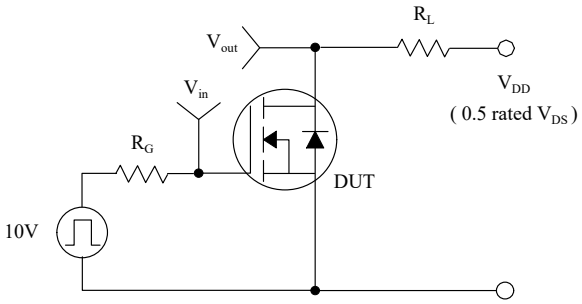
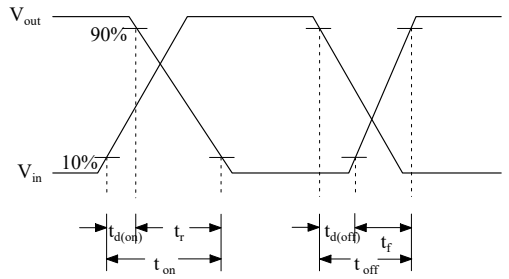
Gate Charge Test Circuit & Waveform



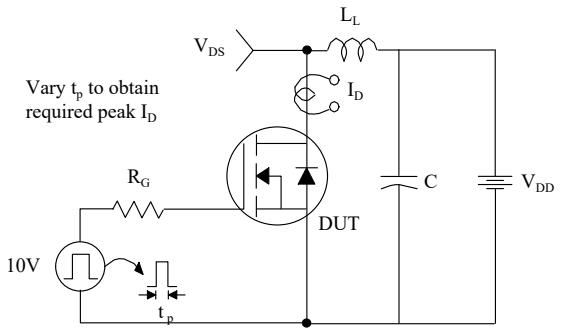


Resistive Switching Test Circuit & Waveforms

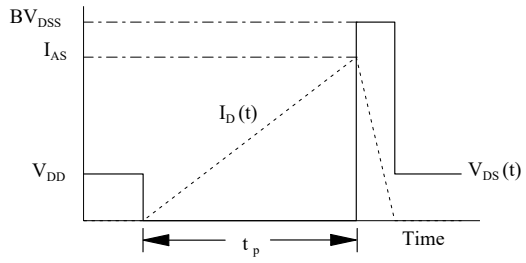




Unclamped Inductive Switching Test Circuit & Waveforms



$$E_{AS} = \frac{1}{2} L_L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$



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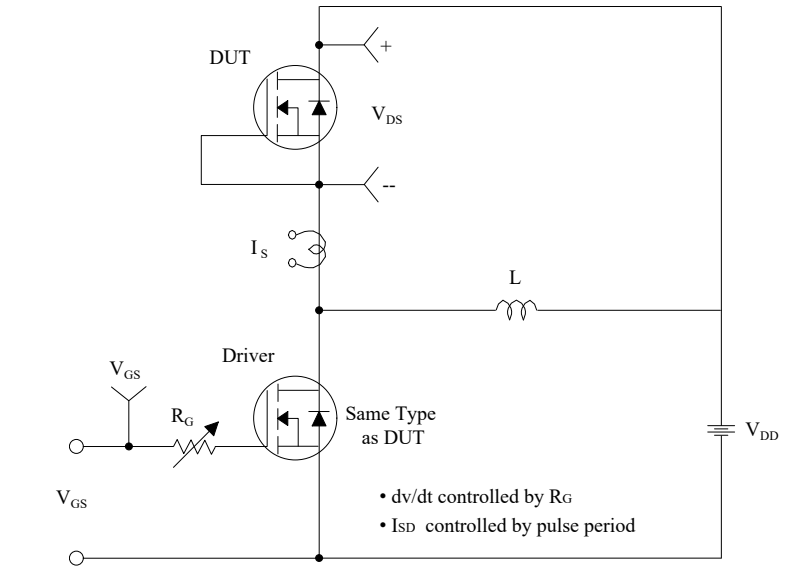
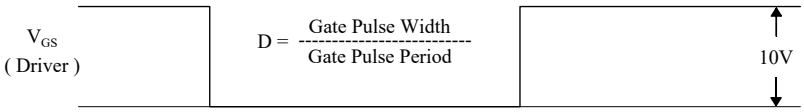
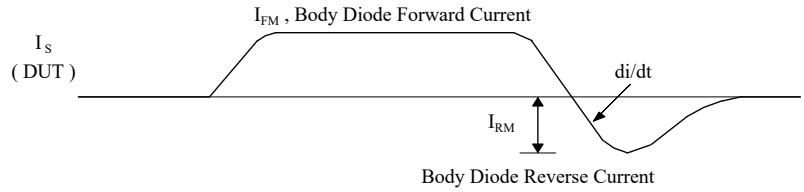
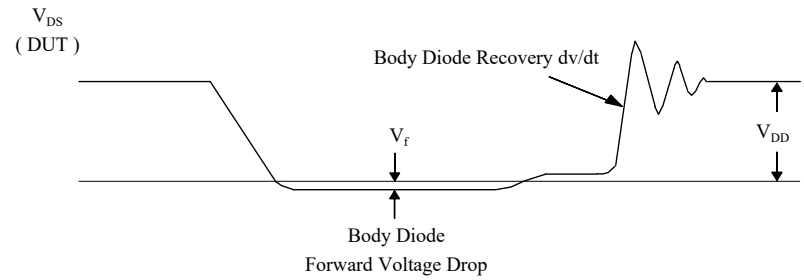
Peak Diode Recovery dv/dt Test Circuit & Waveforms









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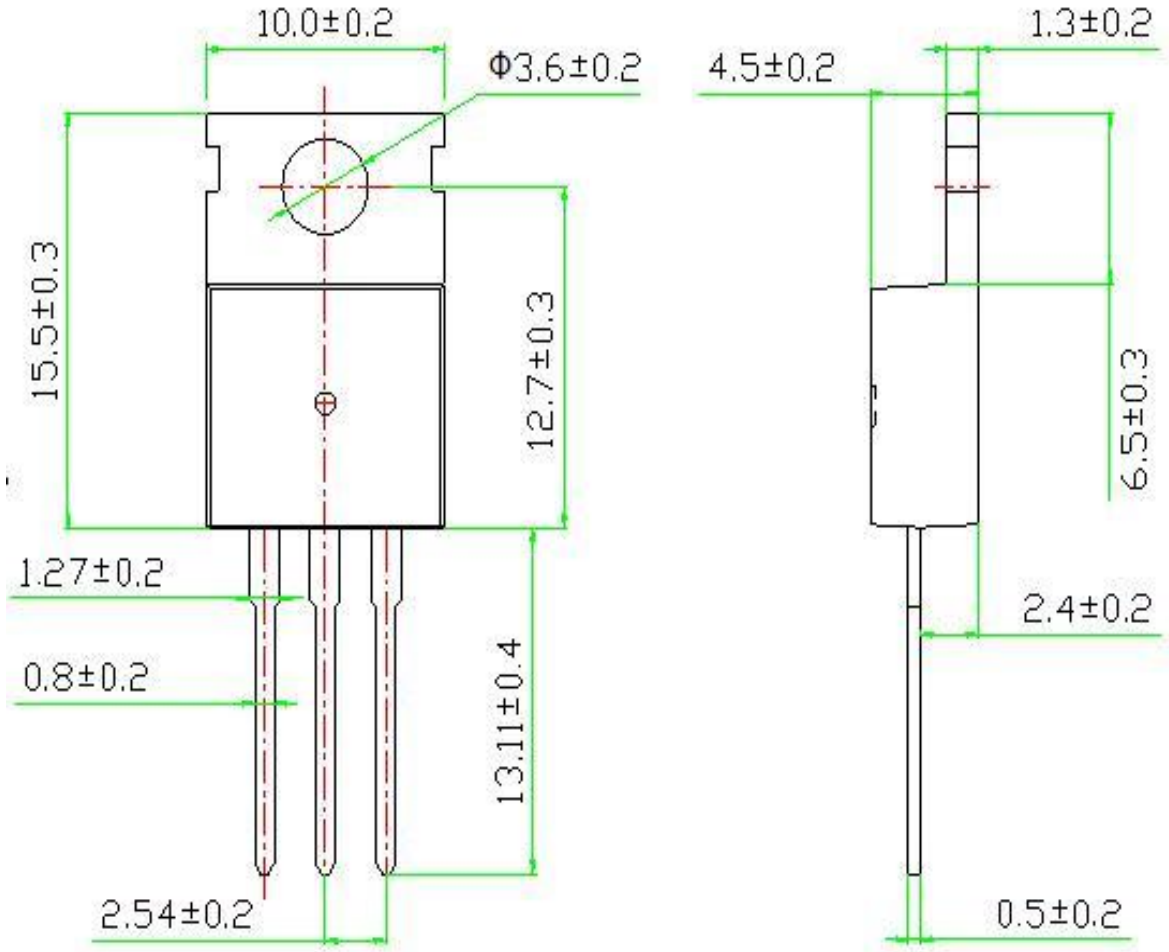
TO-220C OUTLINE



NOTE：

1The plastic package is not marked as smooth surfaceRa =0.1;Subglossy surfaceRa=0.8

2.Undeclared tolerance±0.25,Unmarked filletRmax=0.25

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单击下面可查看定价，库存，交付和生命周期等信息

>>Maplesemi(美浦森半导体)

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